

Operational Amplifiers

LM709 operational amplifier

general description

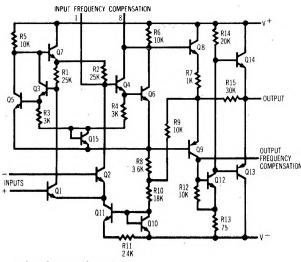
The LM709 is a monolithic operational amplifier intended for general-purpose applications. Operation is completely specified over the range of voltages commonly used for these devices. The design, in addition to providing high gain, minimizes both offset voltage and bias currents. Further, the class-B output stage gives a large output capability with minimum power drain.

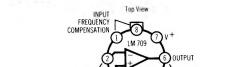
External components are used to frequency compensate the amplifier. Although the unity-gain com-

pensation network specified will make the amplifier unconditionally stable in all feedback configurations, compensation can be tailored to optimize high-frequency performance for any gain setting.

The fact that the amplifier is built on a single silicon chip provides low offset and temperature drift at minimum cost. It also ensures negligible drift due to temperature gradients in the vicinity of the

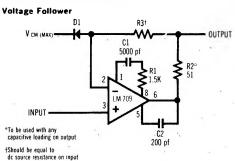
schematic and connection diagrams

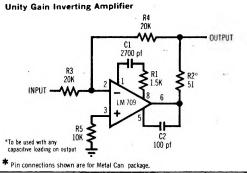




FREQUENCY Pin 4 connected to case

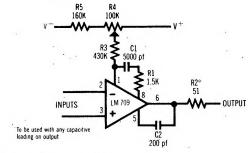
typical applications*



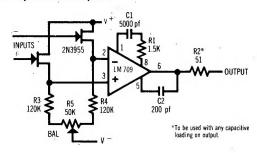


Offset Balancing Circuit

Metal Can



FET Operational Amplifier



absolute maximum ratings

Supply Voltage ±18V Power Dissipation (Note 1) 300 mW Differential Input Voltage ±5V Input Voltage ±10V Output Short-Circuit Duration ($T_A = 25^{\circ}C$) 5 sec -65°C to +150°C Storage Temperature Range -55°C to +125°C Operating Temperature Range Lead Temperature (Soldering, 60 sec) 300°C

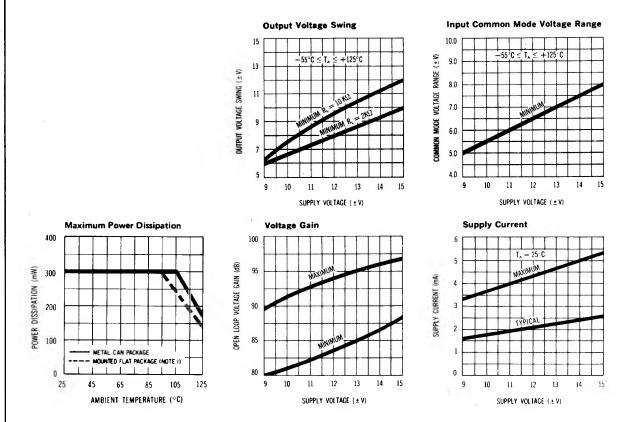
electrical characteristics

PARAMETER	CONDITION	MIN.	TYP.	MAX.	UNITS
Input Offset Voltage	$T_A = 25^{\circ}C$, $R_S \le 10 \text{ k}\Omega$		1.0	5.0	mV
Input Bias Current	T _A = 25°C		200	500	nΑ
Input Offset Current	T _A = 25°C		50	200	nA
Input Resistance	T _A = 25°C	150	400		kΩ
Output Resistance	T _A = 25°C		150		Ω
Supply Current	$T_A = 25^{\circ}C, V_S = \pm 15V$		2.6	5.5	mA
Transient Response Risetime Overshoot	$V_{IN} = 20 \text{ mV}, C_L \le 100 \text{ pF}$ $T_A = 25^{\circ}\text{C}$		0.3 10	1.0 30	μS %
Slewing Rate	T _A = 25°C		0.25		V/μS
Input Offset Voltage	R _S ≤10 kΩ			6.0	mV
Average Temperature Coefficient of Input Offset Voltage	$R_S = 50 \Omega$ $R_S = 10 k\Omega$		3.0 6.0		μV/°(μV/°(
Large-Signal Voltage Gain	$V_S = \pm 15V$, $R_L \ge 2 k\Omega$ $V_{OUT} = \pm 10V$	25,000	45,000	70,000	
Output Voltage Swing	$V_S = \pm 15V$, $R_L = 10 \text{ k}\Omega$	±12	±14		V
	$V_S = \pm 15V$, $R_L = 2 k\Omega$	±10	±13		V
Input Voltage Range	V _S = ±15V	±8.0	±10		V
Common Mode Rejection Ratio	R _S ≤10 kΩ	70	90		db
Supply Voltage Rejection Ratio	R _S ≤10 kΩ		25	150	μ ∨/∨
Input Offset Current	$T_A = +125^{\circ}C$ $T_A = -55^{\circ}C$		20 100	200 500	nA nA
Input Bias Current	$T_A = -55^{\circ}C$		0.5	1.5	μΑ
Input Resistance	T _A = -55°C	40	100		kΩ

Note 1: For operating at elevated temperatures, the device must be derated based on a 150°C maximum junction temperature and a thermal resistance of 150°C/W junction to ambient or 45° C/W junction to case for the metal-can package. For the flat package, the derating is based on a thermal resistance of 185° C/W when mounted on a 1/16-inch-thick, epoxy-glass board with ten, 0.03-inch-wide, 2-ounce copper conductors (see curve).

Note 2: These specifications apply for –55°C \leq T $_{\rm A}$ \leq +125°C, \pm 9V \leq V $_{\rm S}$ \leq +15V, C $_{\rm 1}$ = 5000 pF, R $_{\rm 1}$ = 1.5K, C $_{\rm 2}$ = 200 pF and R $_{\rm 2}$ = 51 Ω unless otherwise specified.

guaranteed performance characteristics



typical performance characteristics

